

1. Global joint venture starts operations as WeEn Semiconductors

Dear customer,

As from November 9th, 2015 NXP Semiconductors N.V. and Beijing JianGuang Asset Management Co. Ltd established Bipolar Power joint venture (JV), **WeEn Semiconductors**, which will be used in future Bipolar Power documents together with new contact details.

In this document where the previous NXP references remain, please use the new links as shown below.

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Thank you for your cooperation and understanding,

WeEn Semiconductors



DISCRETE SEMICONDUCTORS

DATA SHEET

BTH151S-650R Thyristor High Repetitive Surge

Product specification

March 2001



Thyristor High Repetitive Surge

BTH151S-650R

GENERAL DESCRIPTION

Passivated thyristor in a plastic envelope, suitable for surface mounting, intended for use in applications requiring high bidirectional blocking voltage capability and high thermal cycling performance. This thyristor has a high repetitive surge specification which makes it suitable for applications where high inrush currents or stall currents are likely to occur on a repetitive basis.

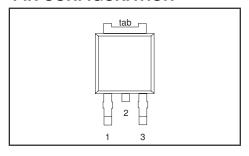
QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{DRM} , V _{RRM} $I_{T(AV)}$ $I_{T(RMS)}$ I_{TSM} I_{TRM}	Repetitive peak off-state voltages Average on-state current RMS on-state current Non-repetitive peak on-state current Repetitive peak on-state current	650 7.5 12 110 60	V A A A

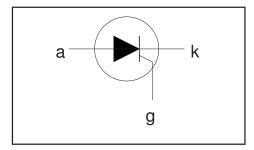
PINNING - SOT428

PIN	DESCRIPTION
1	cathode
2	anode
3	gate
tab	anode

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$egin{array}{c} V_{DRM}, \ V_{RRM} \end{array}$	Repetitive peak off-state voltages	half sine wave;	-	¹ 650	V
I _{T(AV)}	Average on-state current RMS on-state current	T _{mb} ≤ 103 °C all conduction angles	- -	7.5 12	A A
I _{TSM}	Non-repetitive peak on-state current Repetitive peak on-state	half sine wave; $T_j = 25$ °C prior to surge $t = 10$ ms $t = 8.3$ ms $t = 10$ ms, $\tau = 3$ s, $T_{mb} \le 45$ °C, no.	- - -	110 121 60	A A A
l²t dl _⊤ /dt	current I ² t for fusing Repetitive rate of rise of on-state current after	of surges = 100k t = 10 ms $I_{TM} = 20$ A; $I_G = 50$ mA; $dI_G/dt = 50$ mA/ μ s	-	61 50	A²s A/μs
$\begin{matrix} I_{GM} \\ V_{GM} \\ V_{RGM} \\ P_{GM} \\ P_{G(AV)} \\ T_{stg} \\ T_j \end{matrix}$	triggering Peak gate current Peak gate voltage Peak reverse gate voltage Peak gate power Average gate power Storage temperature Operating junction temperature	over any 20 ms period	- - - - -40 -	2 5 5 5 0.5 150 125	°,0%

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

NXP Semiconductors Product specification

Thyristor High Repetitive Surge

BTH151S-650R

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{th j-mb}	Thermal resistance		-	-	1.8	K/W
R _{th j-a}	junction to mounting base Thermal resistance junction to ambient	pcb (FR4) mounted; footprint as in Fig.14	-	75	-	K/W

STATIC CHARACTERISTICS

T_i = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{GT}	Gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$	-	2	15	mA
l I	Latching current	$V_D^2 = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	10	40	mA
l I _H	Holding current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$	-	7	20	mA
ĺΫ́	On-state voltage	$I_{T} = 23 \text{ A}$	-	1.4	1.75	V
V _{GT}	Gate trigger voltage	$\dot{V}_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$	-	0.6	1.5	V
		$V_D = V_{DRM(max)}$; $I_T = 0.1 \text{ A}$; $T_i = 125 ^{\circ}\text{C}$	0.25	0.4	-	V
I_{D}, I_{R}	Off-state leakage current	$V_D = V_{DRM(max)}^{STRM(max)}; V_R = V_{RRM(max)}; T_i = 125 °C$	-	0.1	0.5	mΑ

DYNAMIC CHARACTERISTICS

T_i = 25 °C unless otherwise stated

1 = 0 = 0 = 0 = 0 = 0 = 0 = 0 = 0 = 0 =						
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV _D /dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}; T_j = 125 °C;$ exponential waveform;				
		Gate open circuit	50	130	-	V/μs
		$R_{GK} = 100 \Omega$	200	1000	-	V/µs
t _{gt}	Gate controlled turn-on time	$I_{TM} = 40 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs
t _q	Circuit commutated	$V_D = 67\% V_{DRM(max)}$; $T_j = 125 °C$; $I_{TM} = 20 A$; $V_R = 25 V$; $dI_{TM}/dt = 30 A/\mu s$;	-	70	-	μs
	Lum-on time	$dV_D/dt = 50 \text{ V/}\mu\text{s}; R_{GK} = 100 \Omega$				

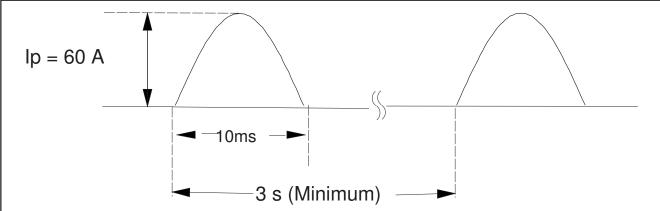


Fig.1. Repetitive surge conditions. $I_P=60A$ (f=50Hz) at $Tc=45^{\circ}C$. Maximum number of cycles n=100k. Repetitive cycle T=3 seconds minimum.

NXP Semiconductors Product specification

Thyristor High Repetitive Surge

BTH151S-650R

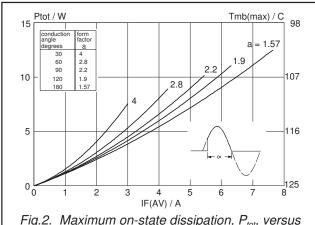


Fig.2. Maximum on-state dissipation, P_{tot} , versus average on-state current, $I_{T(AV)}$, where $a = form \ factor = I_{T(RMS)} / I_{T(AV)}$.

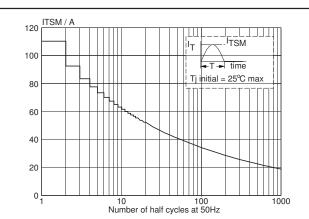


Fig.5. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, f = 50 Hz.

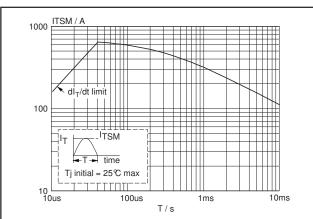


Fig.3. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .

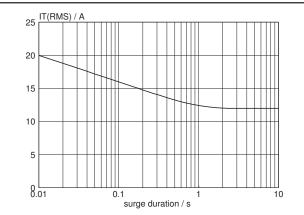


Fig.6. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{mb} \le 103 \,^{\circ}\text{C}$.

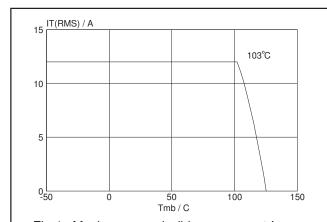
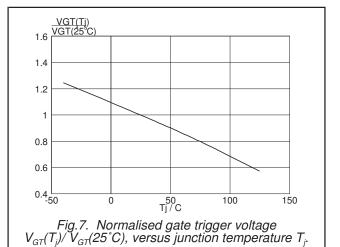


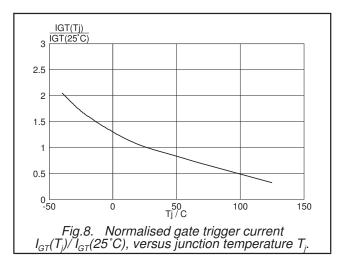
Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .



NXP Semiconductors Product specification

Thyristor High Repetitive Surge

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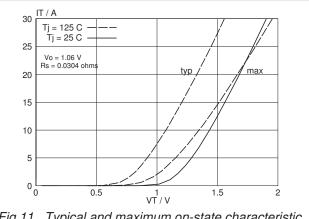
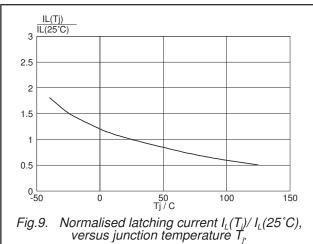
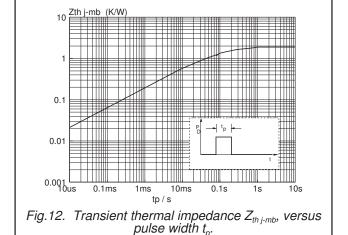
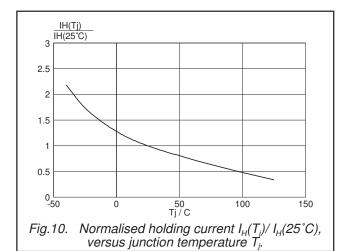


Fig.11. Typical and maximum on-state characteristic.







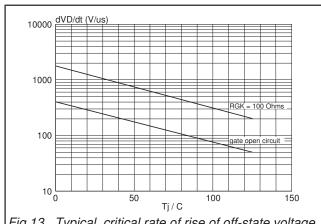


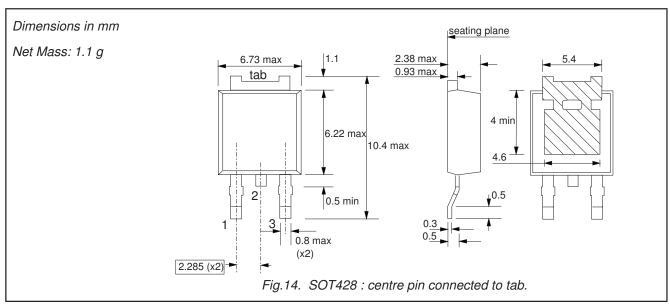
Fig.13. Typical, critical rate of rise of off-state voltage, dV_D/dt versus junction temperature T_i .

NXP Semiconductors Product specification

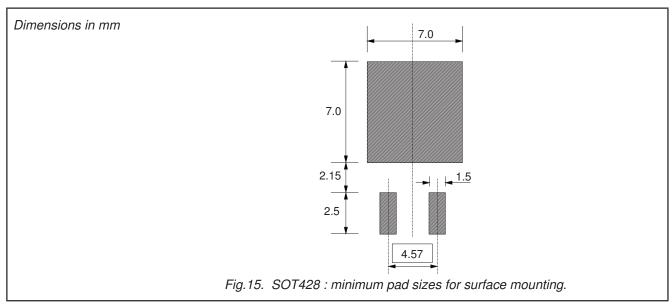
Thyristor High Repetitive Surge

BTH151S-650R

MECHANICAL DATA



MOUNTING INSTRUCTIONS



Notes

1. Plastic meets UL94 V0 at 1/8".

Legal information

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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